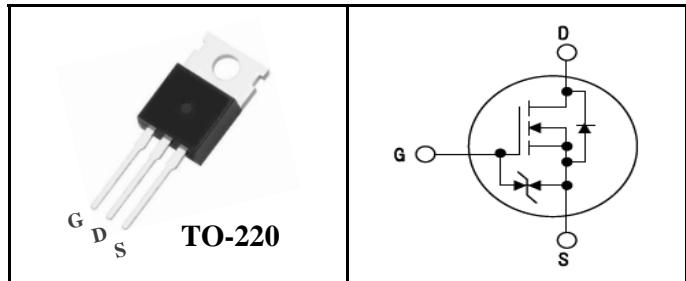


Features 650V N-Channel Super Junction MOSFET

- $BV_{DSS}=650\text{ V}$, $I_D=10.4\text{ A}$
- $R_{DS(on)}:0.38\Omega$ (Max) @ $V_{GS}=10\text{V}$
- Very Low FOM ($R_{DS(on)} \times Q_g$)
- Extremely low switching loss
- Excellent stability and uniformity
- 100% Avalanche Tested
- Built-in ESD Diode



Application

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)
- TV power & LED Lighting Power



Device Marking and Package Information

Device	Package	Marking
MPSP65M380B	TO-220	MP65M380B

Absolute Maximum Ratings

$T_C=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Value	Unit
V_{DSS}	Drain-Source Voltage	650	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Drain Current - Continuous ($T_C = 25^\circ\text{C}$)	10.4 *	A
	Drain Current - Continuous ($T_C = 100^\circ\text{C}$)	6.6 *	A
$I_{DM}^{(1)}$	Drain Current - Pulsed	29.0 *	A
$E_{AS}^{(2)}$	Single Pulsed Avalanche Energy	140	mJ
I_{AR}	Avalanche Current	1.8	A
dv/dt	MOSFET dv/dt ruggedness, $V_{DS}=0\ldots 520\text{V}$	50	V/ns
dv/dt	Reverse diode dv/dt , $V_{DS}=0\ldots 520\text{V}$, $I_{DS} \leq I_D$	15	V/ns
P_D	Power Dissipation ($T_C = 25^\circ\text{C}$)	80	W
$V_{ESD(G-S)}$	Gate source ESD(HBM-C=100pF, R=1.5KΩ)	2500	V
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	°C

* Drain current limited by maximum junction temperature

Thermal Resistance Characteristics

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	1.7	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient , Max.	62.5	°C/W



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MPSP65M380B

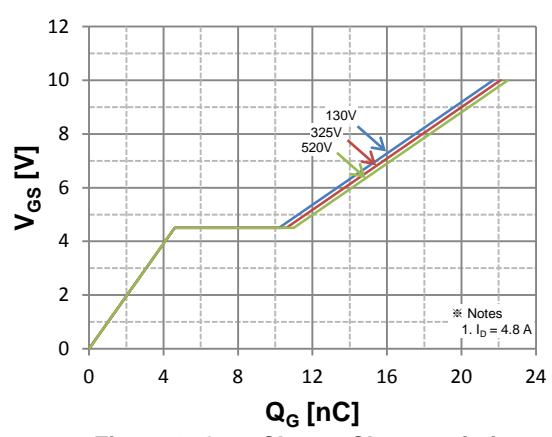
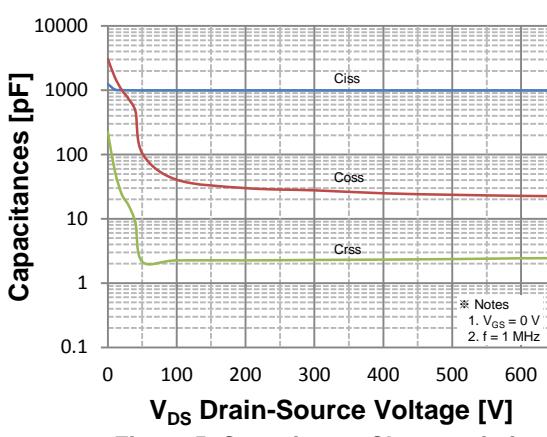
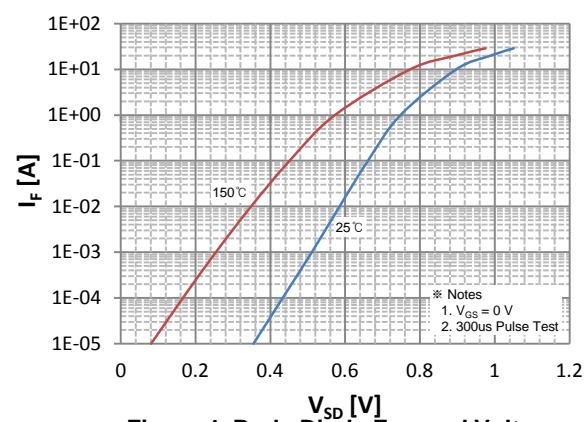
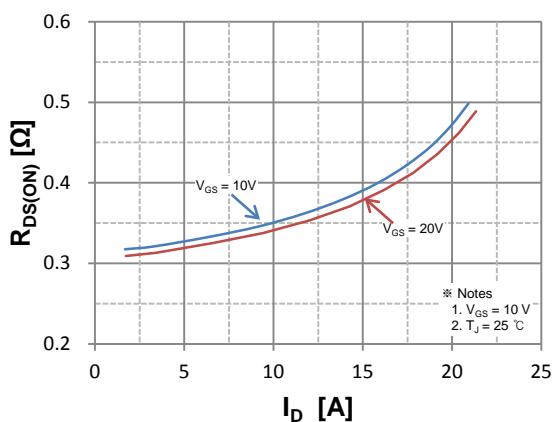
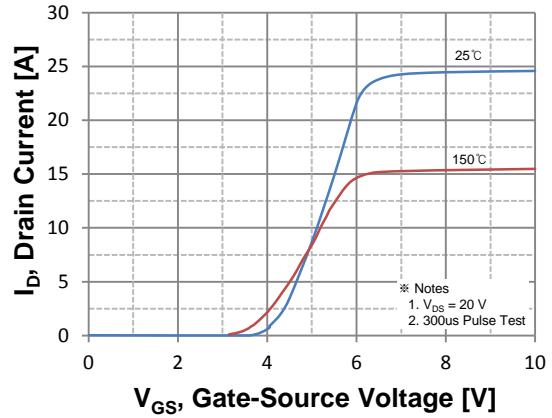
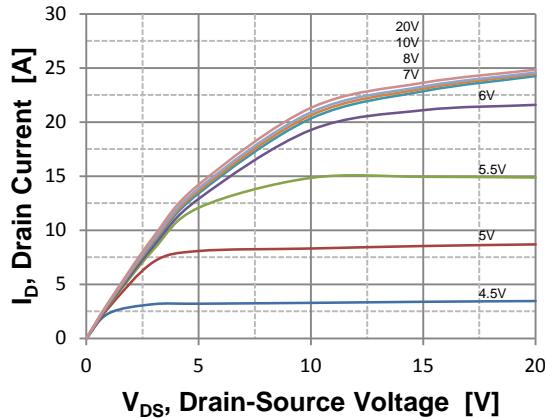
Electrical Characteristics $T_J=25\text{ }^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
On Characteristics						
V_{GS}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 370\text{ }\mu\text{A}$	2.0	-	4.0	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{ V}$, $I_D = 3.4\text{ A}$	-	0.33	0.38	Ω
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}$, $I_D = 1\text{ mA}$	650	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 650\text{ V}$, $V_{GS} = 0$	-	-	1	μA
		$V_{DS} = 650\text{ V}$, $T_C = 150\text{ }^\circ\text{C}$	-	-	100	μA
I_{GSS}	Gate-Body Leakage Current	$V_{GS} = \pm 20\text{ V}$, $V_{DS} = 0\text{ V}$	-	-	± 1	μA
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS} = 100\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1.0\text{ MHz}$	-	990	-	pF
C_{oss}	Output Capacitance		-	40	-	pF
C_{rss}	Reverse Transfer Capacitance		-	2.3	-	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Time	$V_{DS} = 325\text{ V}$, $I_D = 4.8\text{ A}$, $R_G = 25\text{ }\Omega$ (Note 3,4)	-	30	-	ns
t_r	Turn-On Rise Time		-	23	-	ns
$t_{d(off)}$	Turn-Off Delay Time		-	190	-	ns
t_f	Turn-Off Fall Time		-	20	-	ns
Q_g	Total Gate Charge	$V_{DS} = 520\text{ V}$, $I_D = 4.8\text{ A}$, $V_{GS} = 10\text{ V}$ (Note 3,4)	-	22.6	-	nC
Q_{gs}	Gate-Source Charge		-	4.6	-	nC
Q_{gd}	Gate-Drain Charge		-	6.4	-	nC
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain-Source Diode Forward Current	-	-	10.4	A	
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	-	-	29	A	
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0\text{ V}$, $I_S = 4.8\text{ A}$	-	-	1.3	V
trr	Reverse Recovery Time	$V_{GS} = 0\text{ V}$, $I_S = 4.8\text{ A}$ $dI_F/dt = 100\text{ A}/\mu\text{s}$	-	240	-	ns
Qrr	Reverse Recovery Charge		-	2.1	-	μC

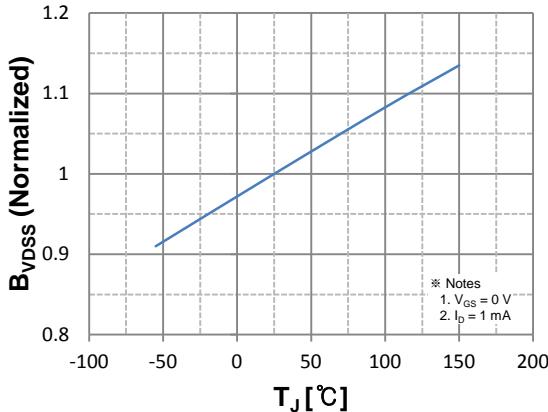
Notes :

- Repetitive Rating : Pulse width limited by maximum junction temperature
- $I_{AS}=1.8\text{ A}$, $V_{DD}=50\text{ V}$, $R_G=25\Omega$, Starting $T_J=25\text{ }^\circ\text{C}$
- Pulse Test : Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
- Essentially Independent of Operating Temperature

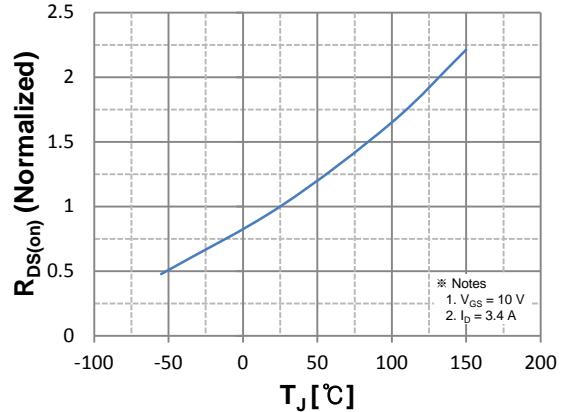
Typical Characteristics



Typical Characteristics



**Figure 7. Breakdown Voltage Variation
vs. Temperature**



**Figure 8. On-Resistance Variation
vs. Temperature**

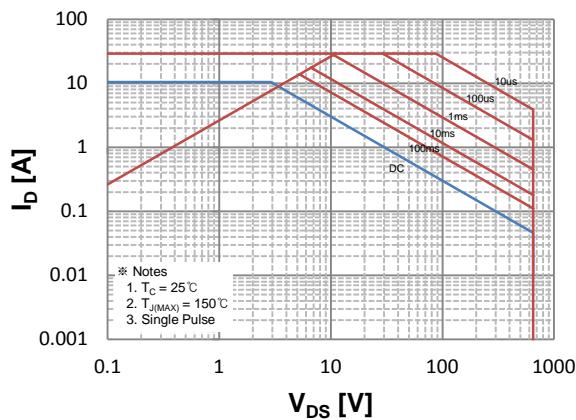
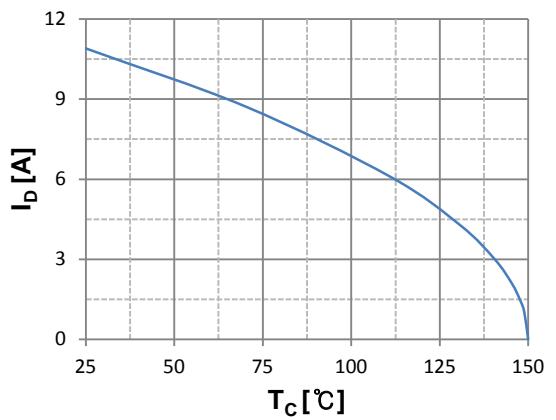


Figure 9. Maximum Safe Operating Area



**Figure 10. Maximum Drain Current
vs. Case Temperature**

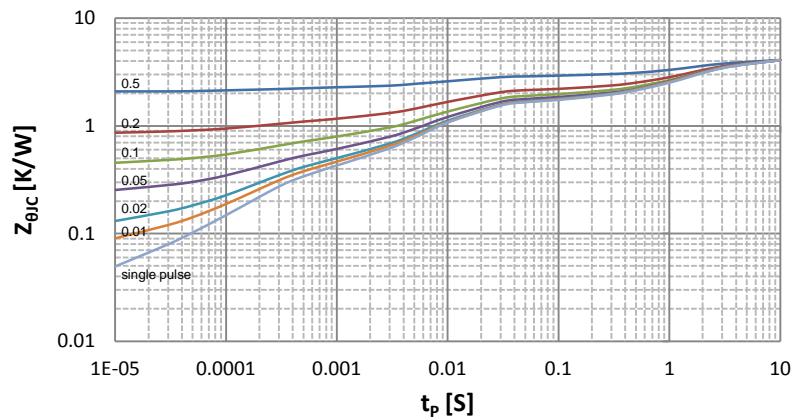


Figure 11. Transient Thermal Response Curve

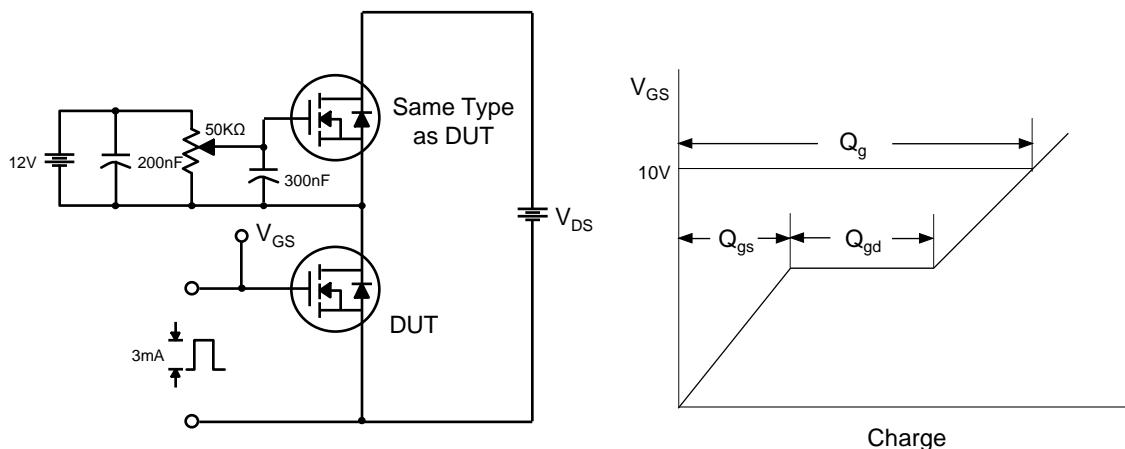
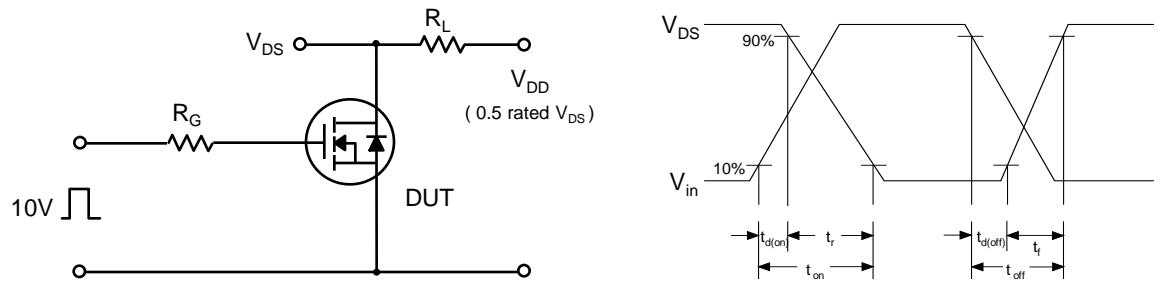
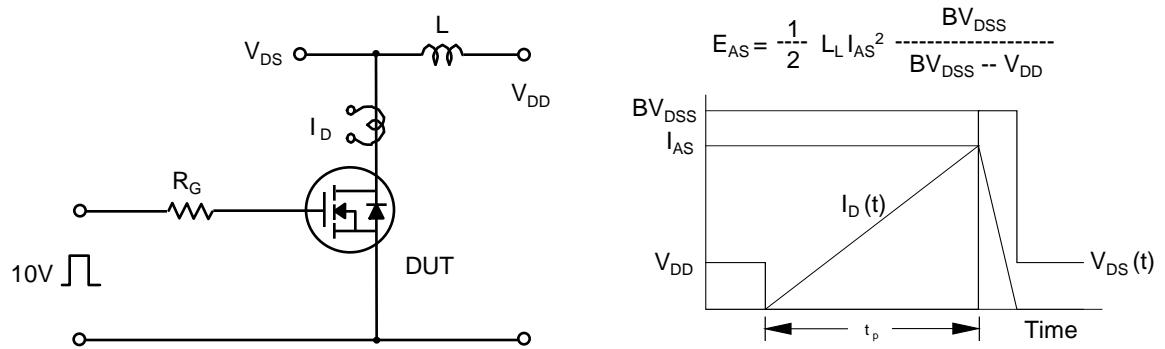
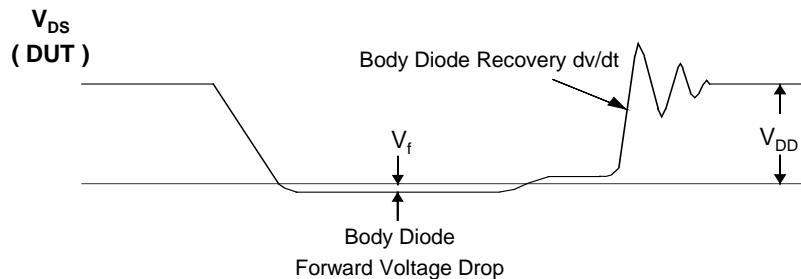
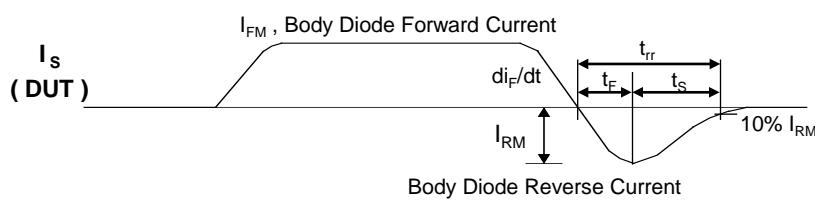
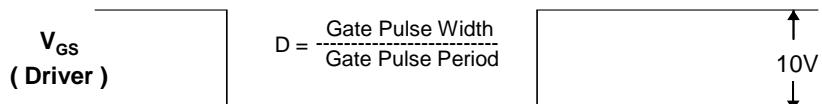
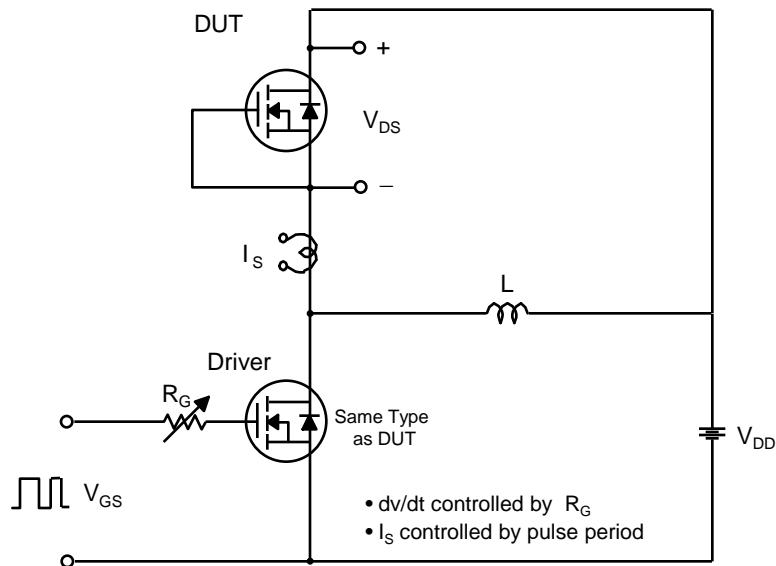
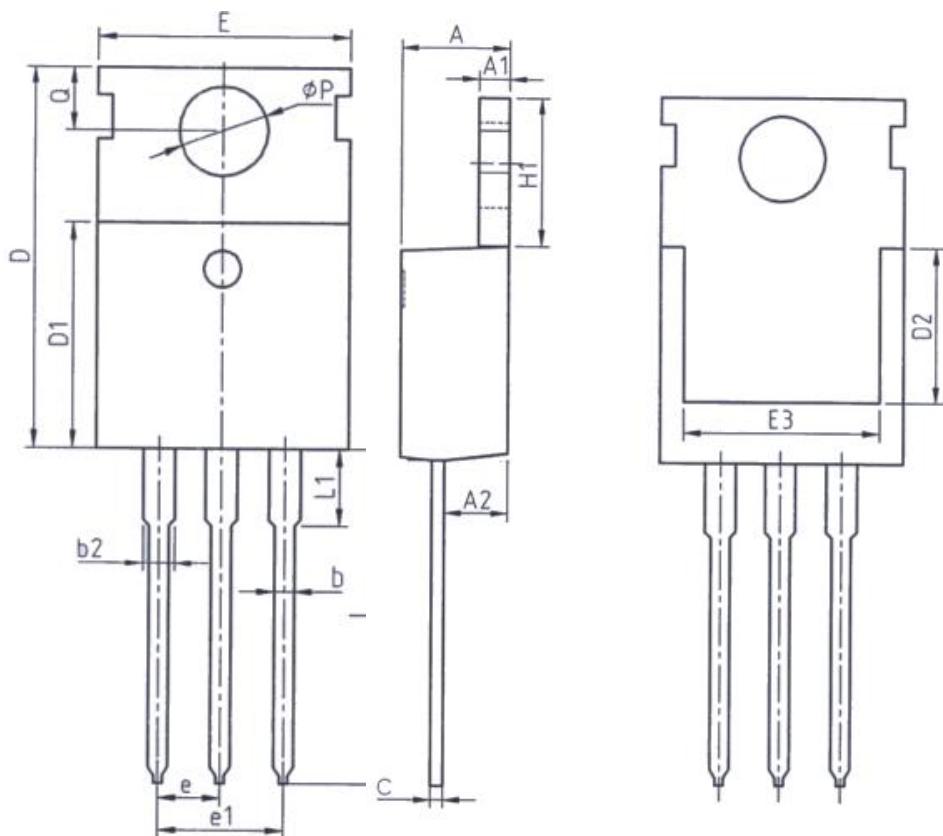
Fig 12. Gate Charge Test Circuit & Waveform

Fig 13. Resistive Switching Test Circuit & Waveforms

Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms


TO-220


Unit: mm		
Symbol	Min.	Max.
A	4.37	4.77
A1	1.25	1.45
A2	2.20	2.60
b	0.70	0.95
b2	1.17	1.47
c	0.40	0.65
D	15.10	16.10
D1	8.80	9.40
D2	5.50	-

Unit: mm		
Symbol	Min.	Max.
E	9.70	10.30
E3	7.00	-
e	2.54BSC	
e1	5.08BSC	
H1	6.25	6.85
L	12.75	13.80
L1	-	3.40
P	3.40	3.80
Q	2.60	3.00